

TOSHIBA Phototransistor Silicon NPN Epitaxial Planar

TPS615(F)

Lead(Pb)-Free

Floppy Disk Drive

VCR

Position Detector Of Home Electric Equipment

Stroboscope

Opto-Electronic Switch

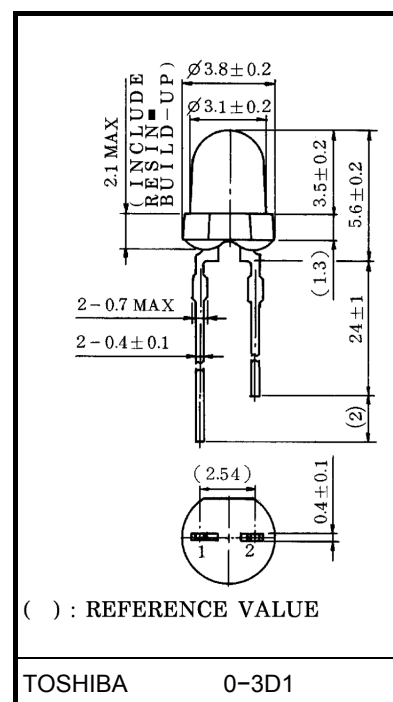
- $\phi 3.1\text{mm}$ epoxy resin package
- Light current: $I_L = 20\mu\text{A}$ (min.) at $E = 0.1\text{mW} / \text{cm}^2$
- Half value angle: $\theta_{1/2} = \pm 30^\circ$ (typ.)

Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-emitter voltage	V_{CEO}	30	V
Emitter-collector voltage	V_{ECO}	5	V
Collector current	I_C	20	mA
Collector power dissipation	P_C	75	mW
Collector power dissipation derating ($T_a > 25^\circ\text{C}$)	$\Delta P_C / ^\circ\text{C}$	-1	mW / $^\circ\text{C}$
Operating temperature range	T_{opr}	-30~85	$^\circ\text{C}$
Storage temperature range	T_{stg}	-30~100	$^\circ\text{C}$

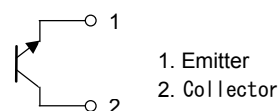
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Unit in mm



Weight: 0.12 g (typ.)

Pin Connection



Opto-Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min.	Typ.	Max.	Unit
Dark current		I_D (I_{CEO})	$V_{CE} = 24\text{ V}$	—	0.01	0.1	μA
Light current		I_L (Note 2)	$V_{CE} = 3\text{ V}$, $E = 0.1\text{ mW / cm}^2$ (Note 1)	20	—	150	μA
Collector-emitter saturation voltage		$V_{CE}(\text{sat})$	$I_C = 10\text{ }\mu\text{A}$, $E = 0.1\text{ mW / cm}^2$ (Note 1)	—	0.2	0.4	V
Peak Sensitivity wavelength		λ_P	—	—	800	—	nm
Half value angle		$\theta_{\frac{1}{2}}$	—	—	± 30	—	°
Switching time	Rise time	t_r	$V_{CC} = 10\text{ V}$, $I_C = 1\text{ mA}$ $R_L = 1\text{ k}\Omega$	—	9	—	μs
	Fall time	t_f		—	10	—	

Note 1: Color temperature = 2870K standard tungsten lamp

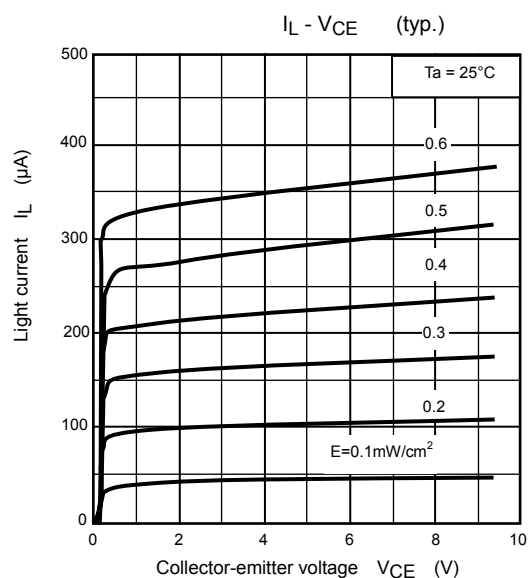
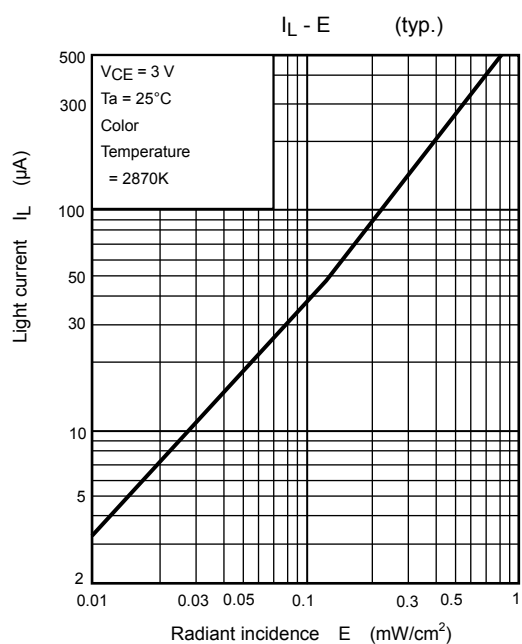
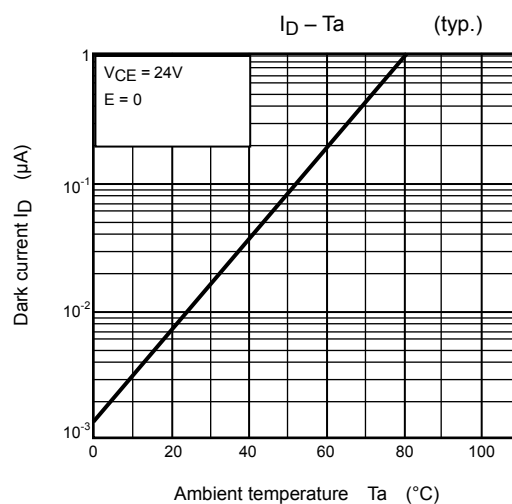
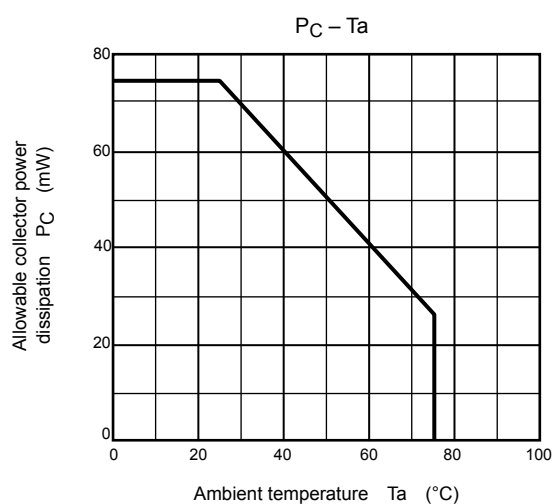
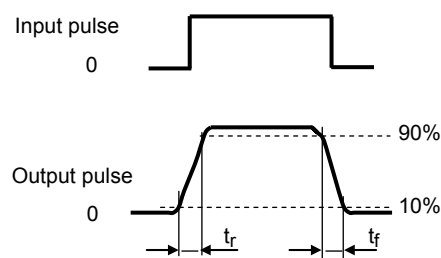
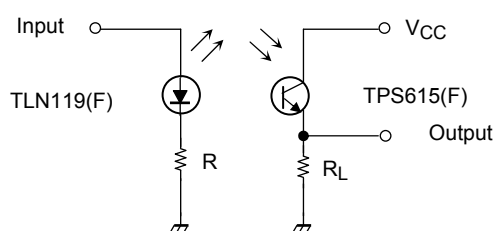
Note 2: I_L Classification A: 20~50 μA , B: 34~85 μA , C: 60~150 μA , AB: 20~85 μA , BC: 34~150 μA

Precaution

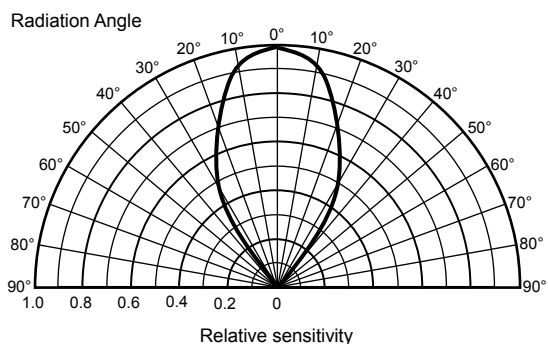
Please be careful of the followings.

- Soldering temperature: 260°C max.
Soldering time: 3s max.
(Soldering portion of lead: above 1.5mm from the body of the device)
- If the lead is formed, the lead should be formed at a distance of 2mm from the body of the device.
Soldering shall be performed after lead forming.

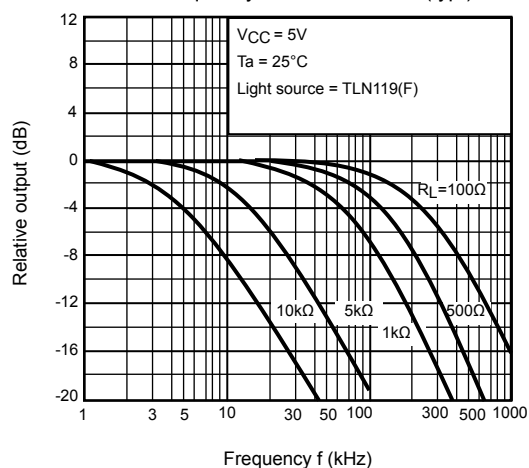
Fig. 1 Switching Time Test Circuit



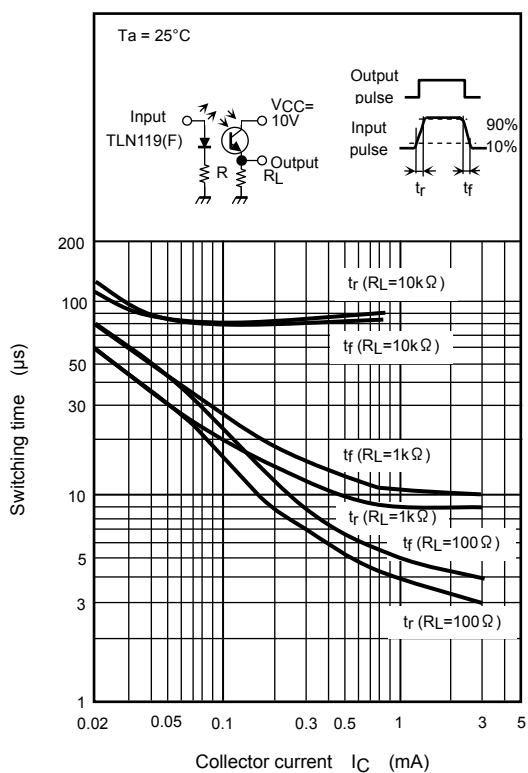
Directional Sensitivity Characteristic
(typ.)
($T_a = 25^\circ\text{C}$)



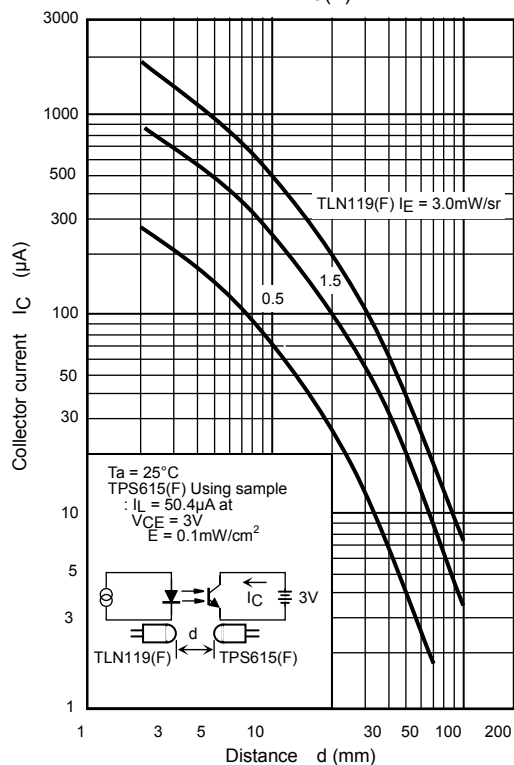
Frequency Characteristics (typ.)

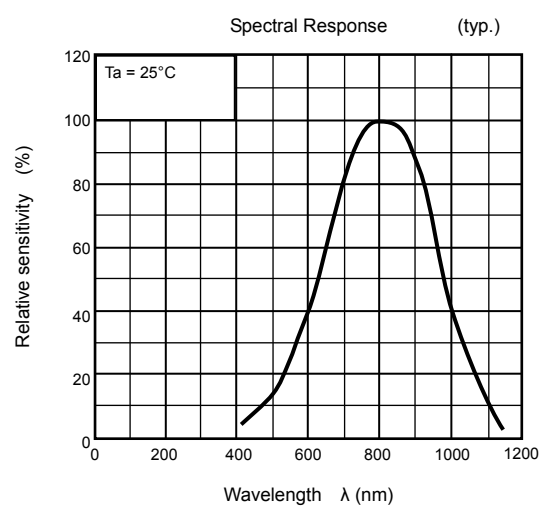


Switching Characteristics (typ.)



Coupling Characteristics With TLN119(F)





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20070701-EN GENERAL

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